

## SiC MOSFET

### CoolSiC™ MOSFET 650 V G2

Built on Infineon's robust 2<sup>nd</sup> generation Silicon Carbide trench technology, the 650 V CoolSiC™ MOSFET delivers unparalleled performance, superior reliability, and great ease of use. It enables cost effective, highly efficient, and simplified designs to fulfill the ever-growing system and market needs.

## Features

- Ultra-low switching losses
- Benchmark gate threshold voltage,  $V_{GS(th)} = 4.5\text{ V}$
- Robust against parasitic turn-on even with 0 V turn-off gate voltage
- Flexible driving voltage and compatible with bipolar driving scheme
- Robust body diode operation under hard commutation events
- .XT interconnection technology for best-in-class thermal performance

## Benefits

- Enables high efficiency and high power density designs
- Facilitates great ease of use and integration
- Provides the best price performance ratio compared to Industry's most ambitious roadmaps
- Reduces the size, weight and bill of materials of the systems
- Enhances system robustness and reliability

## Potential applications

- SMPS
- Solar PV inverters
- Energy storage and battery formation
- UPS
- EV charging infrastructure
- Motor drives

## Product validation

Fully qualified according to JEDEC for Industrial Applications

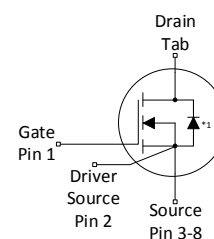
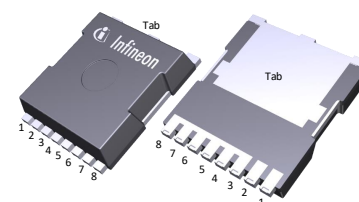
*Please note: The source and driver source pins are not exchangeable. Their exchange might lead to malfunction.*

**Table 1** Key performance parameters

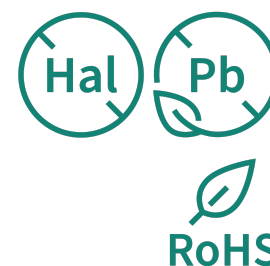
Parameter	Value	Unit
$V_{DSS}$ over full $T_{j,range}$	650	V
$R_{DS(on),typ}$	33	mΩ
$R_{DS(on),max}$	41	mΩ
$Q_{G,typ}$	34	nC
$I_{D,pulse}$	176	A
$Q_{oss} @ 400\text{ V}$	65	nC
$E_{oss} @ 400\text{ V}$	8.7	μJ

Part number	Package	Marking	Related links
IMT65R033M2H	PG-HSOF-8	65R033M2	see Appendix A

TOLL



\*1: Internal body diode



## Table of contents

Description .....	1
Maximum ratings .....	3
Thermal characteristics .....	4
Operating range .....	5
Electrical characteristics .....	6
Electrical characteristics diagrams .....	8
Test circuits .....	13
Package outlines .....	14
Appendix A .....	17
Revision history .....	18
Trademarks .....	18
Disclaimer .....	18

## 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

Note: for optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Continuous DC drain current <sup>1)</sup>	$I_{\text{DDC}}$	-	-	68 48.2	A	$T_c = 25^\circ\text{C}$ $T_c = 100^\circ\text{C}$
Peak drain current <sup>2)</sup>	$I_{\text{DM}}$	-	-	176	A	$T_c = 25^\circ\text{C}$ , $V_{\text{GS}} = 18\text{ V}$
Avalanche energy, single pulse	$E_{\text{AS}}$	-	-	162	mJ	$I_D = 6\text{ A}$ , $V_{\text{DD}} = 50\text{ V}$ ; see table 11
Avalanche energy, repetitive	$E_{\text{AR}}$	-	-	0.81	mJ	
Avalanche current, single pulse	$I_{\text{AS}}$	-	-	6.0	A	-
MOSFET $dv/dt$ ruggedness	$dv/dt$	-	-	200	V/ns	$V_{\text{DS}} = 0 \dots 400\text{ V}$
Gate source voltage (static) <sup>3)</sup>	$V_{\text{GS}}$	-7	-	23	V	-
Gate source voltage (transient)	$V_{\text{GS}}$	-10	-	25	V	$t_p \leq 500\text{ ns}$ , duty cycle $\leq 1\%$
Power dissipation	$P_{\text{tot}}$	-	-	312	W	$T_c = 25^\circ\text{C}$
Storage temperature	$T_{\text{stg}}$	-55	-	150	$^\circ\text{C}$	-
Operating junction temperature	$T_j$	-55	-	175	$^\circ\text{C}$	
Mounting torque	-	-	-	n.a.	Ncm	
Continuous reverse drain current <sup>1)</sup>	$I_{\text{SDC}}$	-	-	68 48.8	A	$V_{\text{GS}} = 18\text{ V}$ , $T_c = 25^\circ\text{C}$ $V_{\text{GS}} = 0\text{ V}$ , $T_c = 25^\circ\text{C}$
Peak reverse drain current <sup>2)</sup>	$I_{\text{SM}}$	-	-	176 52	A	$T_c = 25^\circ\text{C}$ , $t_p \leq 250\text{ ns}$ $T_c = 25^\circ\text{C}$
Insulation withstand voltage	$V_{\text{ISO}}$	-	-	n.a.	V	$V_{\text{rms}}$ , $T_c = 25^\circ\text{C}$ , $t = 1\text{ min}$

<sup>1)</sup> Limited by  $T_{j,\text{max}}$ .

<sup>2)</sup> Pulse width  $t_{\text{pulse}}$  limited by  $T_{j,\text{max}}$ .

<sup>3)</sup> The maximum gate-source voltage in the application design should be in accordance to IPC-9592B.

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{th(j-c)}$	-	-	0.48	°C/W	Not subject to production test. Parameter verified by design/characterization according to JESD51-14.
Soldering temperature, reflow soldering allowed	$T_{solder}$	-	-	260	°C	reflow MSL3

### 3 Operating range

**Table 4**    **Operating range**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Recommended turn-on voltage	$V_{GS(on)}$	-	18	-	V	-
Recommended turn-off voltage	$V_{GS(off)}$	-	0	-	V	

## 4 Electrical characteristics

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 5 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source voltage	$V_{\text{DSS}}$	650	-	-	V	$V_{\text{GS}} = 0\text{ V}$ , $I_{\text{D}} = 0.57\text{ mA}$
Gate threshold voltage <sup>4)</sup>	$V_{\text{GS(th)}}$	3.5	4.5	5.6	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_{\text{D}} = 5.7\text{ mA}$
Zero gate voltage drain current	$I_{\text{DSS}}$	-	1 3	75 -	$\mu\text{A}$	$V_{\text{DS}} = 650\text{ V}$ , $V_{\text{GS}} = 0\text{ V}$ , $T_j = 25^\circ\text{C}$ $V_{\text{DS}} = 650\text{ V}$ , $V_{\text{GS}} = 0\text{ V}$ , $T_j = 175^\circ\text{C}$
Gate-source leakage current	$I_{\text{GSS}}$	-	-	100	nA	$V_{\text{GS}} = 20\text{ V}$ , $V_{\text{DS}} = 0\text{ V}$
Drain-source on-state resistance	$R_{\text{DS(on)}}$	-	43 33 30 54	- 41 - -	$\text{m}\Omega$	$V_{\text{GS}} = 15\text{ V}$ , $I_{\text{D}} = 27.9\text{ A}$ , $T_j = 25^\circ\text{C}$ $V_{\text{GS}} = 18\text{ V}$ , $I_{\text{D}} = 27.9\text{ A}$ , $T_j = 25^\circ\text{C}$ $V_{\text{GS}} = 20\text{ V}$ , $I_{\text{D}} = 27.9\text{ A}$ , $T_j = 25^\circ\text{C}$ $V_{\text{GS}} = 18\text{ V}$ , $I_{\text{D}} = 27.9\text{ A}$ , $T_j = 175^\circ\text{C}$
Internal gate resistance	$R_{\text{G,int}}$	-	3.1	-	$\Omega$	$f = 1\text{ MHz}$

<sup>4)</sup> Tested after 1 ms pulse at  $V_{\text{GS}} = +20\text{ V}$ . "Linear mode" operation is not recommended. For assessment of potential "linear mode" operation, please contact Infineon sales office.

**Table 6 Dynamic characteristics**

External parasitic elements (PCB layout) influence switching behavior significantly.

Stray inductances and coupling capacitances must be minimized.

For layout recommendations please use provided application notes or contact Infineon sales office.

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance	$C_{\text{iss}}$	-	1215	-	pF	$V_{\text{GS}} = 0\text{ V}$ , $V_{\text{DS}} = 400\text{ V}$ , $f = 250\text{ kHz}$
Reverse transfer capacitance	$C_{\text{rss}}$	-	7.0	-	pF	
Output capacitance <sup>5)</sup>	$C_{\text{oss}}$	-	90	117	pF	
Output charge <sup>5)</sup>	$Q_{\text{oss}}$	-	65	84	nC	calculation based on $C_{\text{oss}}$
Effective output capacitance, energy related <sup>6)</sup>	$C_{\text{o(er)}}$	-	109	-	pF	$V_{\text{GS}} = 0\text{ V}$ , $V_{\text{DS}} = 0 \dots 400\text{ V}$
Effective output capacitance, time related <sup>7)</sup>	$C_{\text{o(tr)}}$	-	161	-	pF	$I_{\text{D}} = \text{constant}$ , $V_{\text{GS}} = 0\text{ V}$ , $V_{\text{DS}} = 0 \dots 400\text{ V}$
Turn-on delay time	$t_{\text{d(on)}}$	-	8.8	-	ns	$V_{\text{DD}} = 400\text{ V}$ , $V_{\text{GS}} = 0/18\text{ V}$ , $I_{\text{D}} = 27.9\text{ A}$ , $R_{\text{G,ext}} = 1.8\text{ }\Omega$ ; see table 10
Rise time	$t_{\text{r}}$	-	9.1	-	ns	
Turn-off delay time	$t_{\text{d(off)}}$	-	15	-	ns	
Fall time	$t_{\text{f}}$	-	4.8	-	ns	

**Table 6 Dynamic characteristics**

External parasitic elements (PCB layout) influence switching behavior significantly.  
 Stray inductances and coupling capacitances must be minimized.  
 For layout recommendations please use provided application notes or contact Infineon sales office.

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Turn-ON switching losses <sup>8)</sup>	$E_{on}$	-	35	-	μJ	$V_{DD} = 400\text{ V}$ , $V_{GS} = 0/18\text{ V}$ , $I_D = 27.9\text{ A}$ , $R_{G,ext} = 1.8\ \Omega$
Turn-OFF switching losses <sup>8)</sup>	$E_{off}$	-	22	-	μJ	
Total switching losses <sup>8)</sup>	$E_{tot}$	-	57	-	μJ	

<sup>5)</sup> Maximum specification is defined by calculated six sigma upper confidence bound.

<sup>6)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.

<sup>7)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.

<sup>8)</sup> Values for 4-pin configuration based on TO-263-7 measurements; MOSFET used in half-bridge configuration without external diode.

**Table 7 Gate charge characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Plateau gate to source charge	$Q_{GS(pl)}$	-	8.8	-	nC	$V_{DD} = 400\text{ V}$ , $I_D = 27.9\text{ A}$ , $V_{GS} = 0\text{ to }18\text{ V}$
Gate to drain charge	$Q_{GD}$	-	6.4	-	nC	
Total gate charge	$Q_G$	-	34	-	nC	

**Table 8 Reverse diode characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source reverse voltage	$V_{SD}$	-	4.3	-	V	$V_{GS} = 0\text{ V}$ , $I_S = 27.9\text{ A}$ , $T_J = 25^\circ\text{C}$
MOSFET forward recovery time	$t_{fr}$	-	13.7 9	-	ns	$V_{DD} = 400\text{ V}$ , $I_S = 27.9\text{ A}$ , $di_S/dt = 1000\text{ A}/\mu\text{s}$ ; see table 9 $V_{DD} = 400\text{ V}$ , $I_S = 27.9\text{ A}$ , $di_S/dt = 4000\text{ A}/\mu\text{s}$ ; see table 9
MOSFET forward recovery charge <sup>9)</sup>	$Q_{fr}$	-	67 103	-	nC	$V_{DD} = 400\text{ V}$ , $I_S = 27.9\text{ A}$ , $di_S/dt = 1000\text{ A}/\mu\text{s}$ ; see table 9 $V_{DD} = 400\text{ V}$ , $I_S = 27.9\text{ A}$ , $di_S/dt = 4000\text{ A}/\mu\text{s}$ ; see table 9
MOSFET peak forward recovery current	$I_{frm}$	-	9.8 23	-	A	$V_{DD} = 400\text{ V}$ , $I_S = 27.9\text{ A}$ , $di_S/dt = 1000\text{ A}/\mu\text{s}$ ; see table 9 $V_{DD} = 400\text{ V}$ , $I_S = 27.9\text{ A}$ , $di_S/dt = 4000\text{ A}/\mu\text{s}$ ; see table 9

<sup>9)</sup>  $Q_{fr}$  includes  $Q_{oss}$ .

## 5 Electrical characteristics diagrams

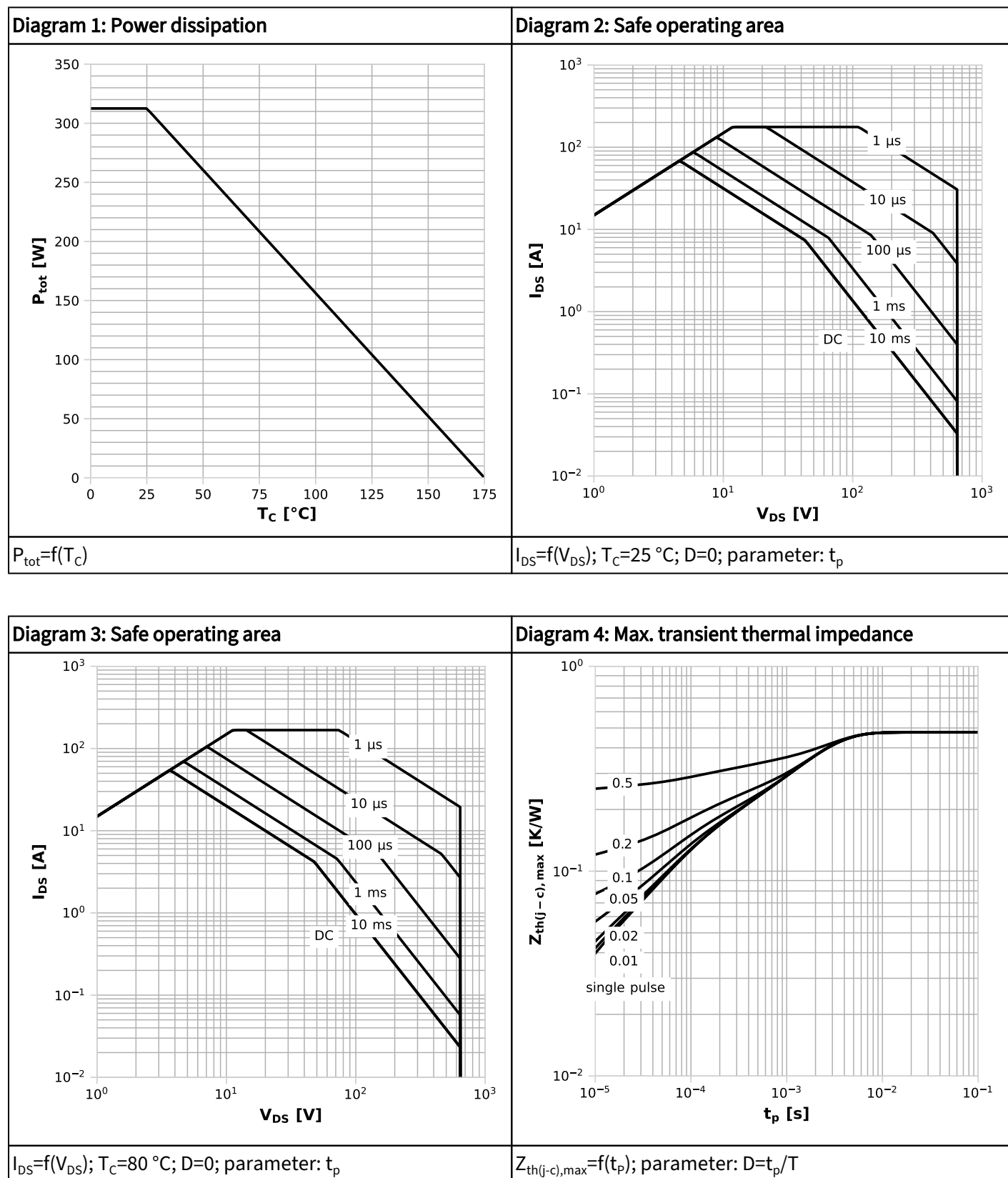
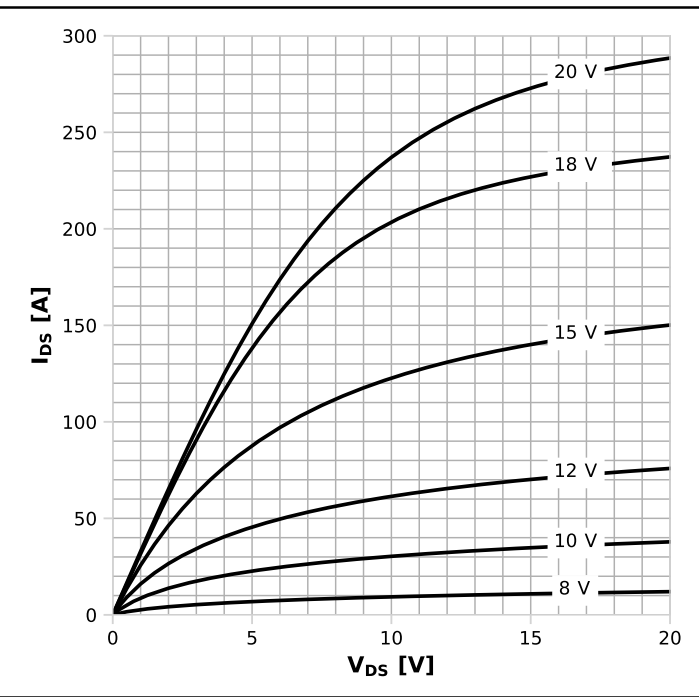


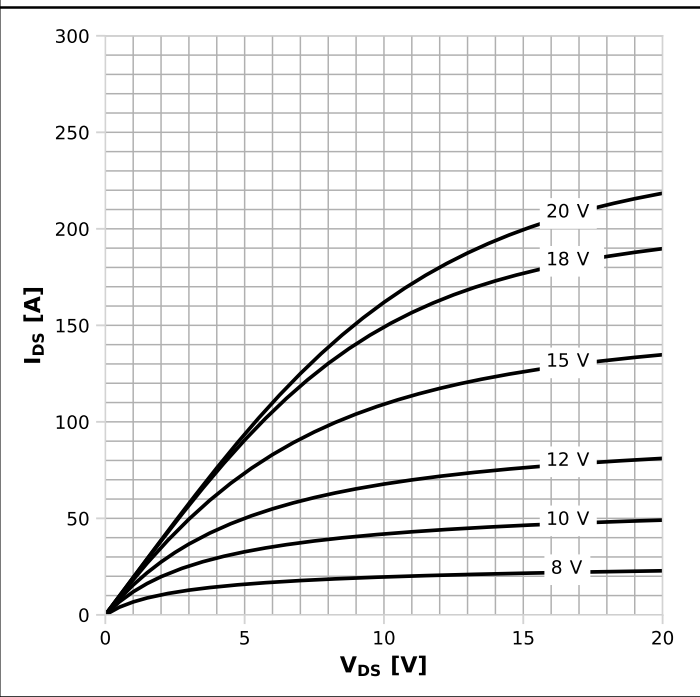


Diagram 5: Typ. output characteristics



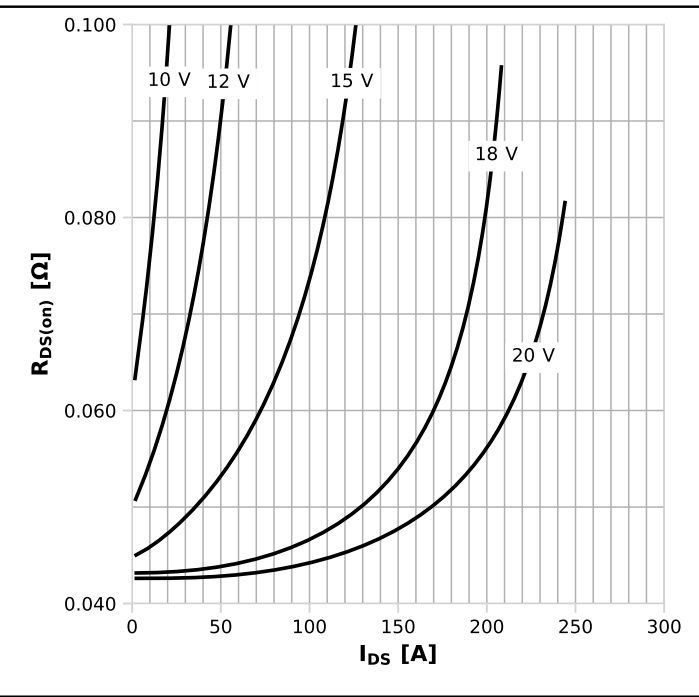
$I_{DS}=f(V_{DS})$ ;  $T_j=25\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. output characteristics



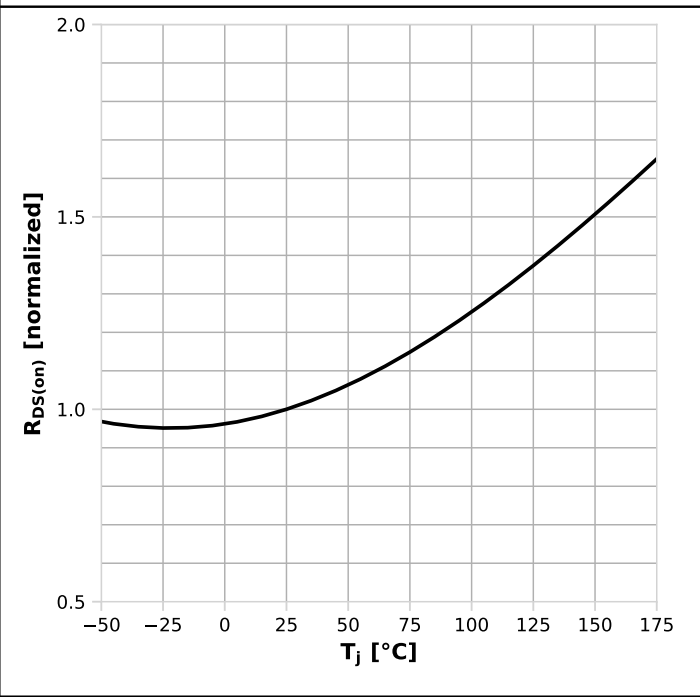
$I_{DS}=f(V_{DS})$ ;  $T_j=175\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. drain-source on-state resistance



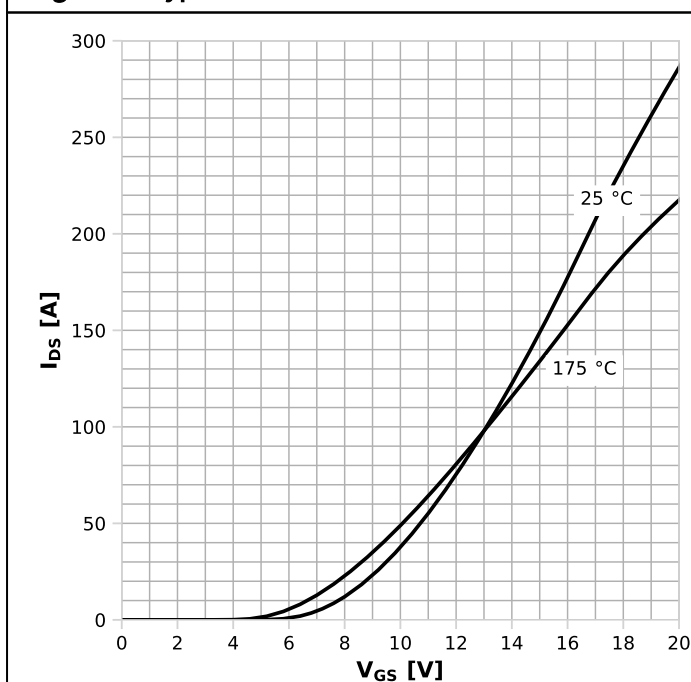
$R_{DS(on)}=f(I_{DS})$ ;  $T_j=125\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 8: Drain-source on-state resistance



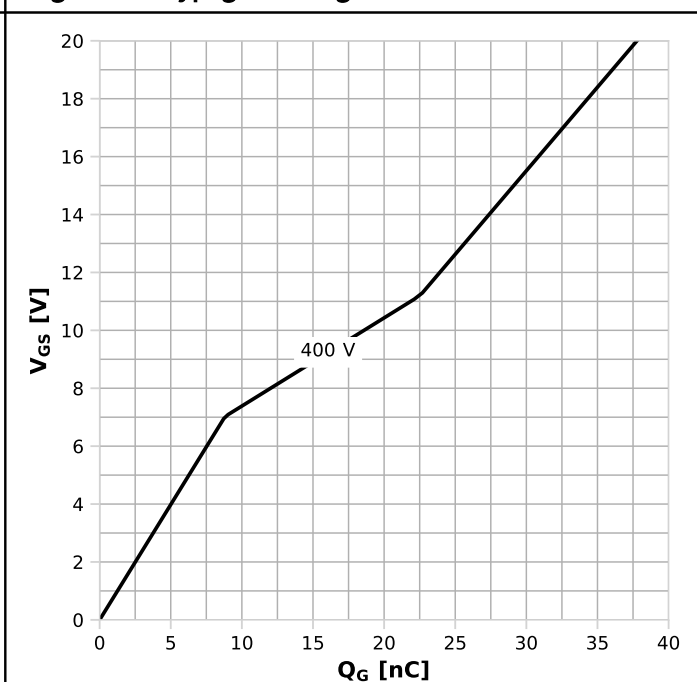
$R_{DS(on)}=f(T_j)$ ;  $I_D=27.9\text{ A}$ ;  $V_{GS}=18\text{ V}$

Diagram 9: Typ. transfer characteristics



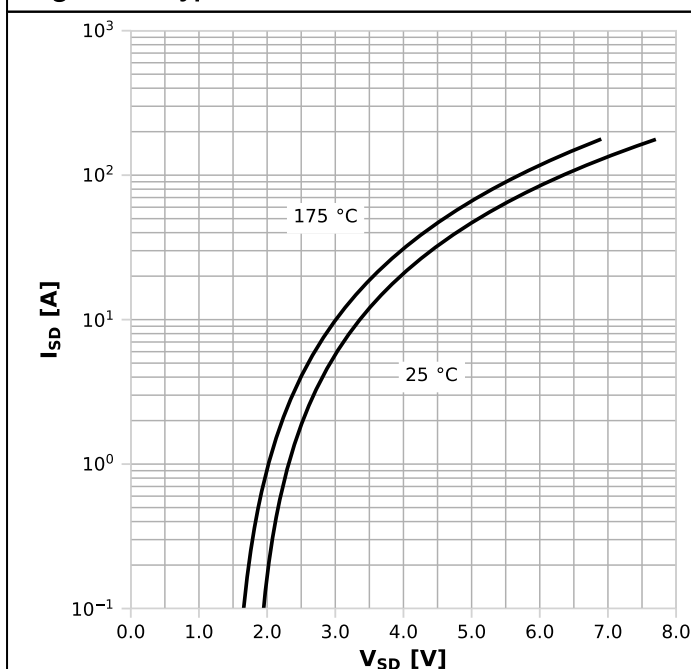
$I_{DS}=f(V_{GS})$ ;  $V_{DS}=20$  V; parameter:  $T_j$

Diagram 10: Typ. gate charge



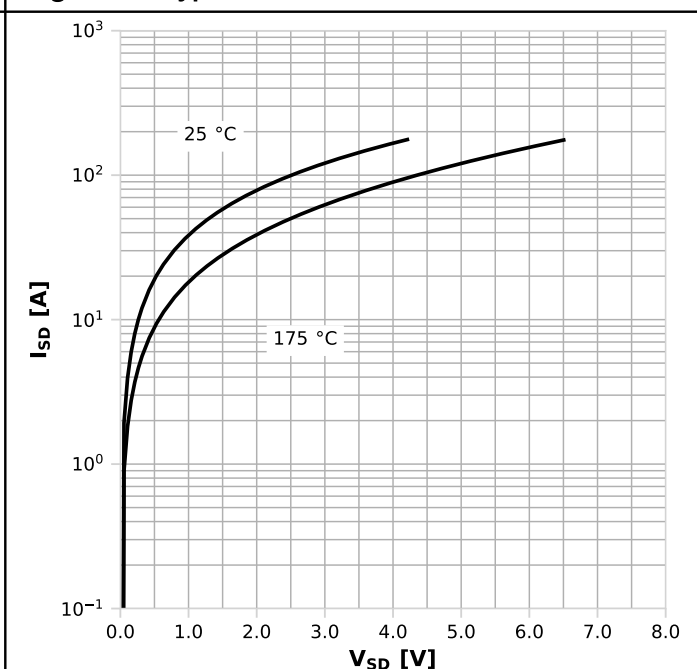
$V_{GS}=f(Q_G)$ ;  $I_D=27.9$  A pulsed; parameter:  $V_{DD}$

Diagram 11: Typ. reverse drain current characteristics



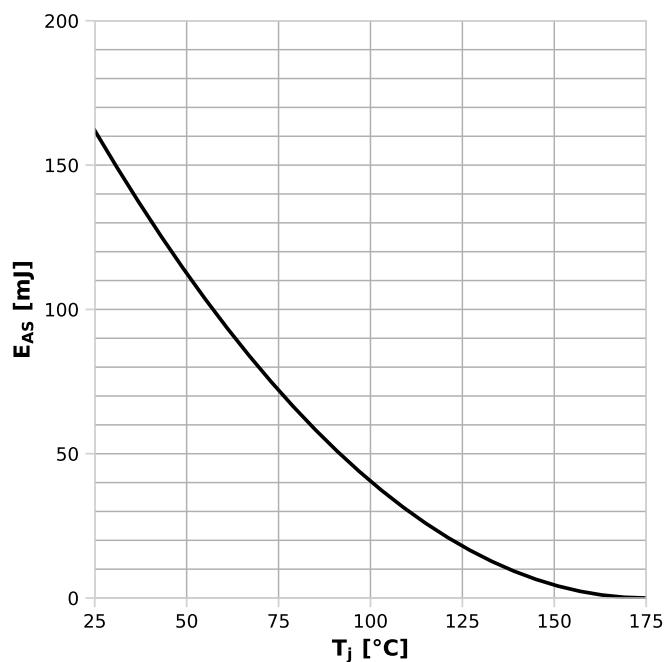
$I_{SD}=f(V_{SD})$ ;  $V_{GS}=0$  V; parameter:  $T_j$

Diagram 12: Typ. reverse drain current characteristics



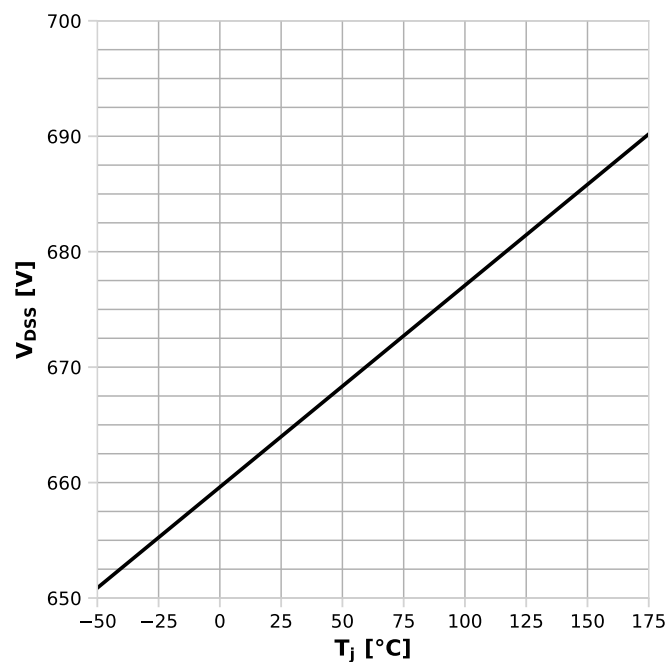
$I_{SD}=f(V_{SD})$ ;  $V_{GS}=18$  V; parameter:  $T_j$

Diagram 13: Avalanche energy



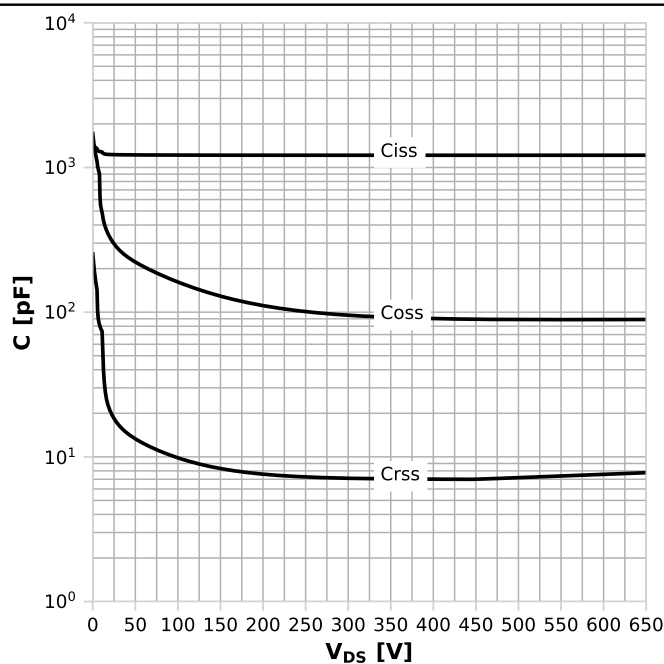
$E_{AS}=f(T_J)$ ;  $I_D=6.0$  A;  $V_{DD}=50$  V

Diagram 14: Drain-source breakdown voltage



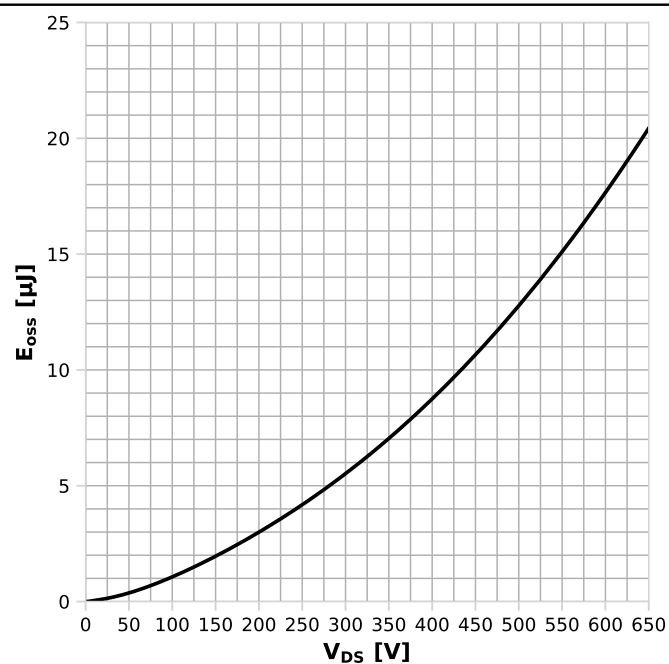
$V_{DSS}=f(T_J)$ ;  $I_D=0.57$  mA

Diagram 15: Typ. capacitances



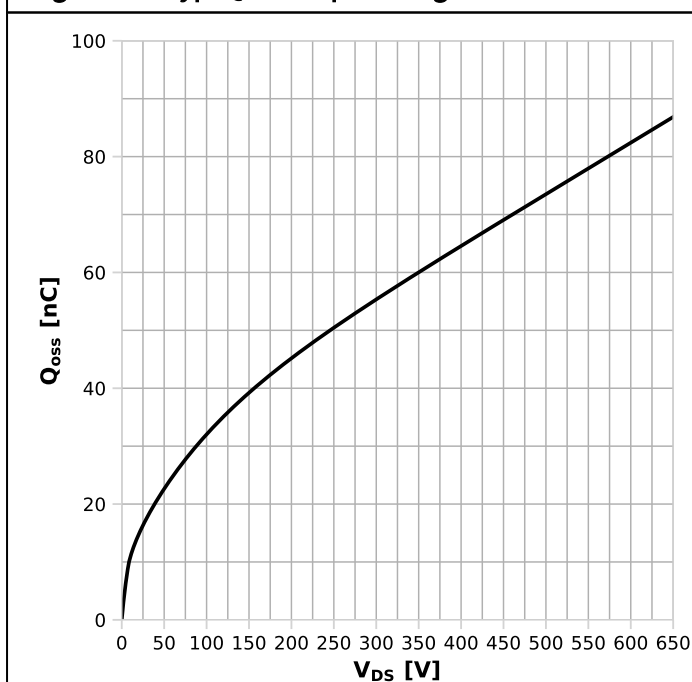
$C=f(V_{DS})$ ;  $V_{GS}=0$  V;  $f=250$  kHz

Diagram 16: Typ. Coss stored energy



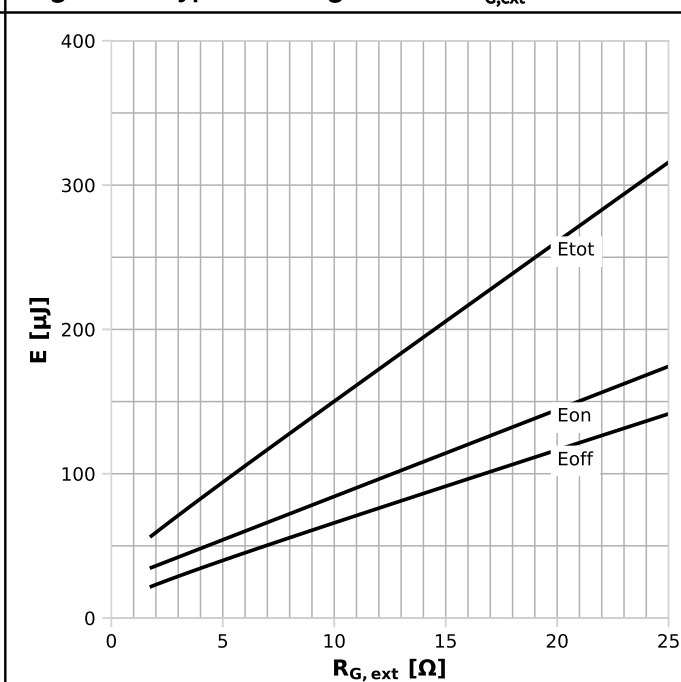
$E_{OSS}=f(V_{DS})$

Diagram 17: Typ. Qoss output charge



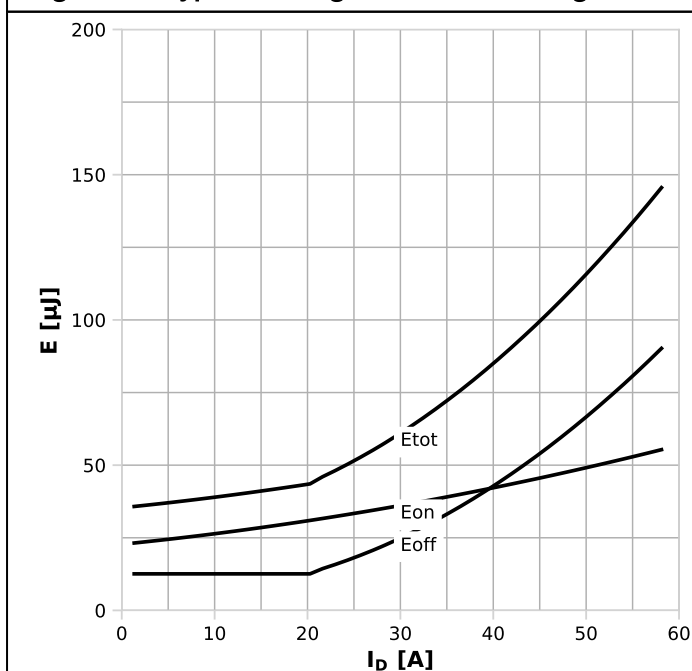
$Q_{oss}=f(V_{DS})$

Diagram 18: Typ. Switching Losses vs  $R_{G,ext}$



$E=f(R_{G,ext}); V_{DD}=400\text{ V}; V_{GS}=0-18\text{ V}; I_D=27.9\text{ A}$

Diagram 19: Typ. Switching Losses vs switching current



$E=f(I_D); V_{DD}=400\text{ V}; V_{GS}=0-18\text{ V}; R_{G,ext}=1.8\text{ Ω}$

6 Test circuits

Table 9 Body diode characteristics



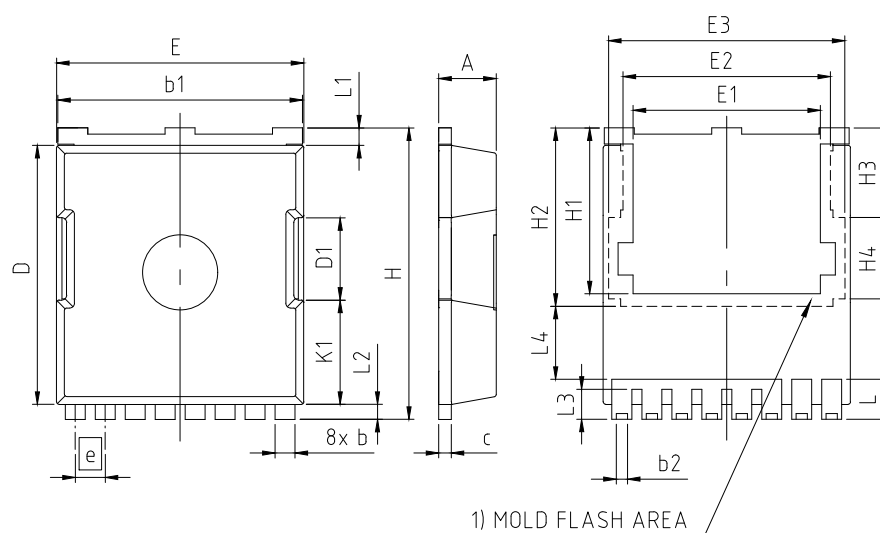
Table 10 Switching times



Table 11 Unclamped inductive load



## 7 Package outlines

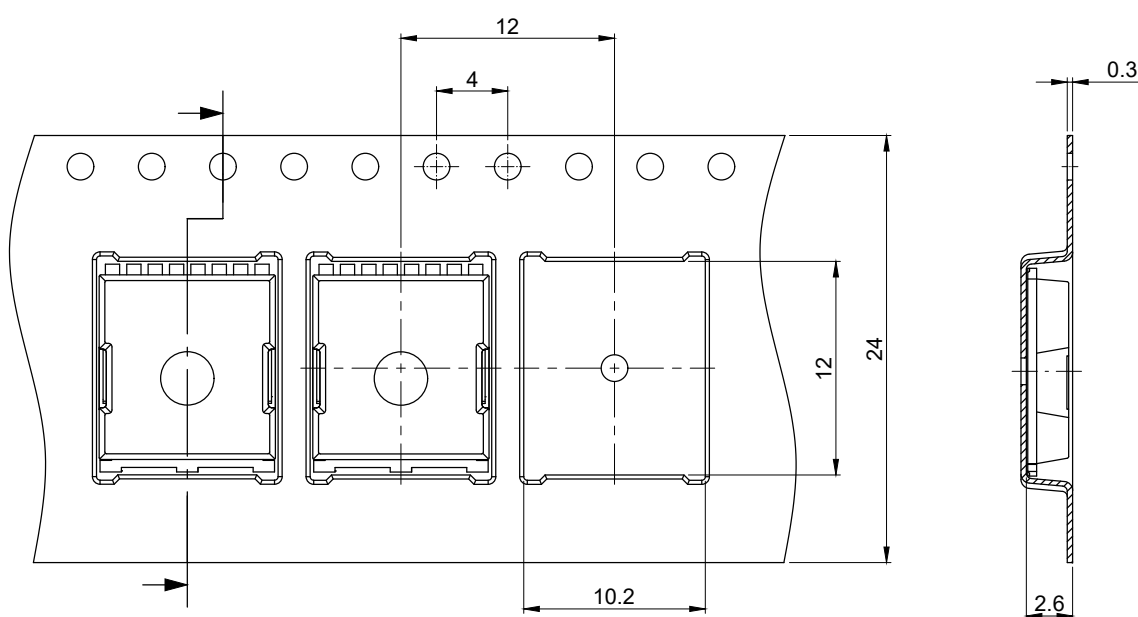


PACKAGE - GROUP NUMBER: <b>PG-HSOF-8-U02</b>		
DIMENSIONS	MILLIMETERS	
	MIN.	MAX.
<b>A</b>	2.20	2.40
<b>b</b>	0.70	0.90
<b>b1</b>	9.70	9.90
<b>b2</b>	0.42	0.50
<b>c</b>	0.40	0.60
<b>D</b>	10.28	10.58
<b>D1</b>	3.30	
<b>E</b>	9.70	10.10
<b>E1</b>	7.50	
<b>E2</b>	8.50	
<b>E3</b>	9.46	
<b>e</b>	1.20 (BSC)	
<b>H</b>	11.48	11.88
<b>H1</b>	6.55	6.95
<b>H2</b>	7.15	
<b>H3</b>	3.59	
<b>H4</b>	3.26	
<b>N</b>	8	
<b>K1</b>	4.18	
<b>L</b>	1.40	1.80
<b>L1</b>	0.50	0.90
<b>L2</b>	0.50	0.70
<b>L3</b>	1.00	1.30
<b>L4</b>	2.62	2.81


1) PARTIALLY COVERED WITH MOLD FLASH

**Figure 1** Outline PG-HSOF-8, dimensions in mm





All dimensions are in units mm

The drawing is in compliance with ISO 128-30, Projection Method 1 [  ]

**Figure 3** Packaging variant PG-HSOF-8, dimensions in mm



## 8 Appendix A

**Table 12**    **Related links**

- [IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Webpage](#)
- [IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Application Note](#)
- [IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Simulation Model](#)
- [IFX Design tools](#)

## Revision history

IMT65R033M2H

### Revision 2025-01-16, Rev. 2.1

Previous revisions

Revision	Date	Subjects (major changes since last revision)
2.0	2024-11-06	Release of final
2.1	2025-01-16	updated continuous reverse drain current

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